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(12) **United States Design Patent** (10) **Patent No.:** **US D984,909 S**
Singh et al. (45) **Date of Patent:** **** May 2, 2023**

(54) **THERMOMETER PROBE**

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(**) Term: **15 Years**

(21) Appl. No.: **29/756,605**

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(51) **LOC (14) Cl.** **10-04**

(52) **U.S. Cl.**
USPC **D10/60**

(58) **Field of Classification Search**
USPC D10/50, 53, 56, 57, 58, 60, 104.1, 104.2,
D10/121; D24/135, 186, 187
CPC G01K 1/08; G01K 1/14; G01K 13/20;
G01K 2207/02
See application file for complete search history.

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Assistant Examiner — Lillian Windham
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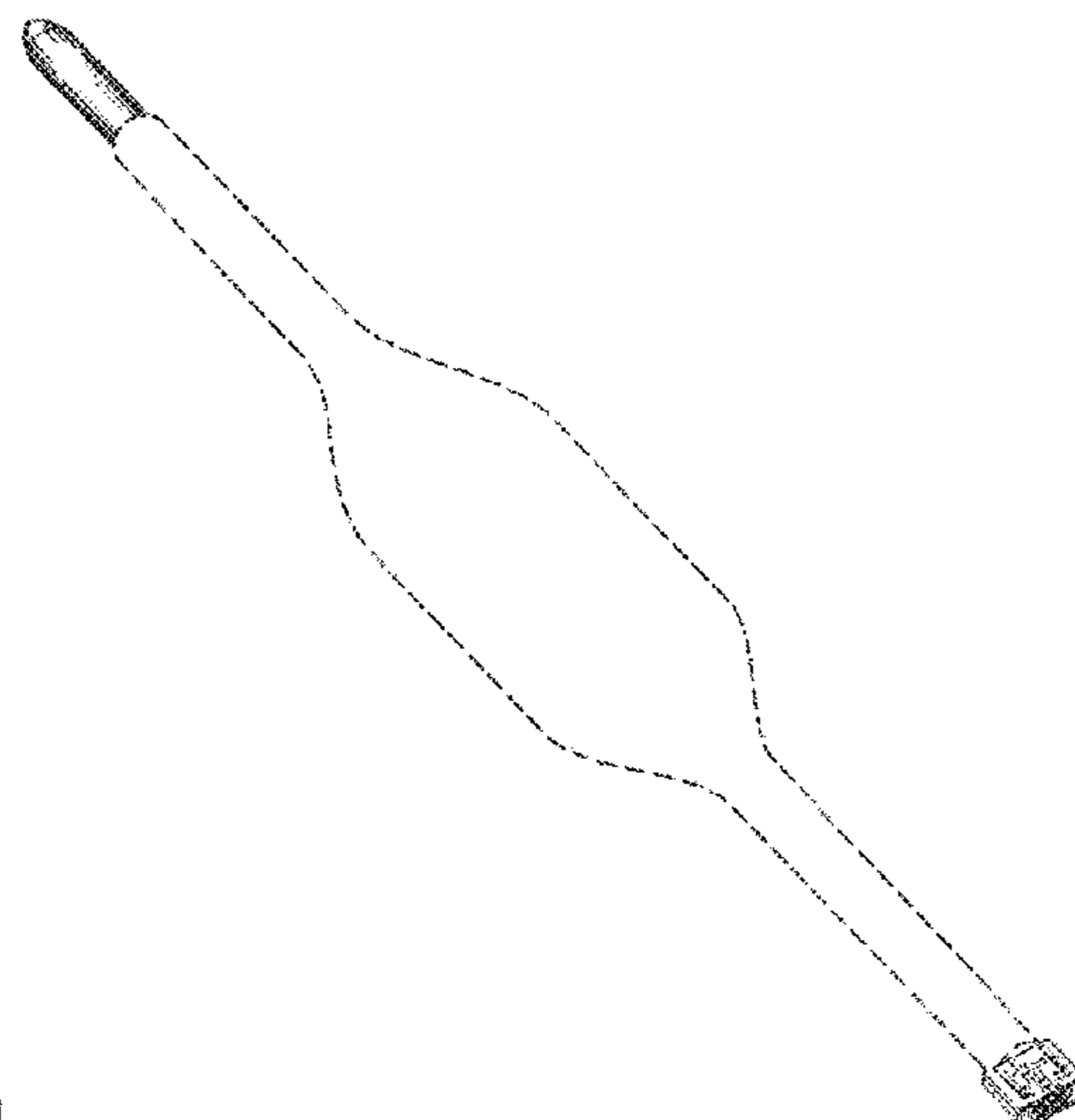
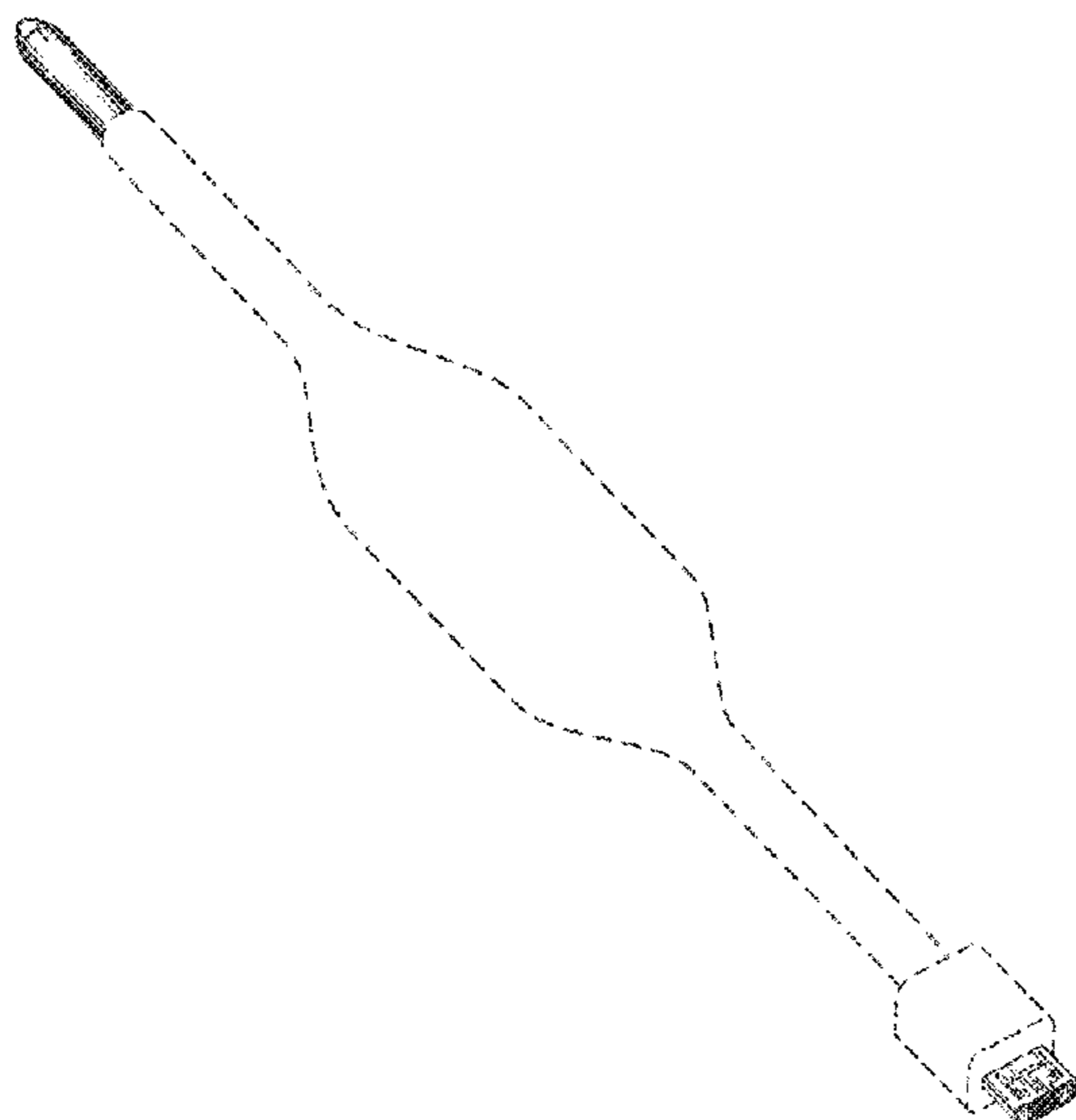
(57) **CLAIM**

The ornamental design for a thermometer probe, as shown and described.

DESCRIPTION

FIG. 1 is a top perspective view of a thermometer probe showing a first image in a first embodiment of the claimed design;
FIG. 2 is a bottom perspective view thereof;
FIG. 3 is a front view thereof;
FIG. 4 is a back view thereof;
FIG. 5 is a side view thereof;
FIG. 6 is a bottom view thereof;
FIG. 7 is a top view thereof;
FIG. 8 is a top perspective view of a thermometer probe showing a first image in a second embodiment of the claimed design;
FIG. 9 is a bottom perspective view thereof;
FIG. 10 is a front view thereof;
FIG. 11 is a back view thereof;
FIG. 12 is a side view thereof;
FIG. 13 is a bottom view thereof;
FIG. 14 is a top view thereof;
FIG. 15 is a top perspective view of a thermometer probe showing a first image in a third embodiment of the claimed design;
FIG. 16 is a bottom perspective view thereof;
FIG. 17 is a front view thereof;
FIG. 18 is a back view thereof;
FIG. 19 is a side view thereof;
FIG. 20 is a bottom view thereof; and,
FIG. 21 is a top view thereof.
The broken lines are included for the purpose of illustrating portions of the thermometer probe that form no part of the claimed design.

1 Claim, 18 Drawing Sheets



(56)

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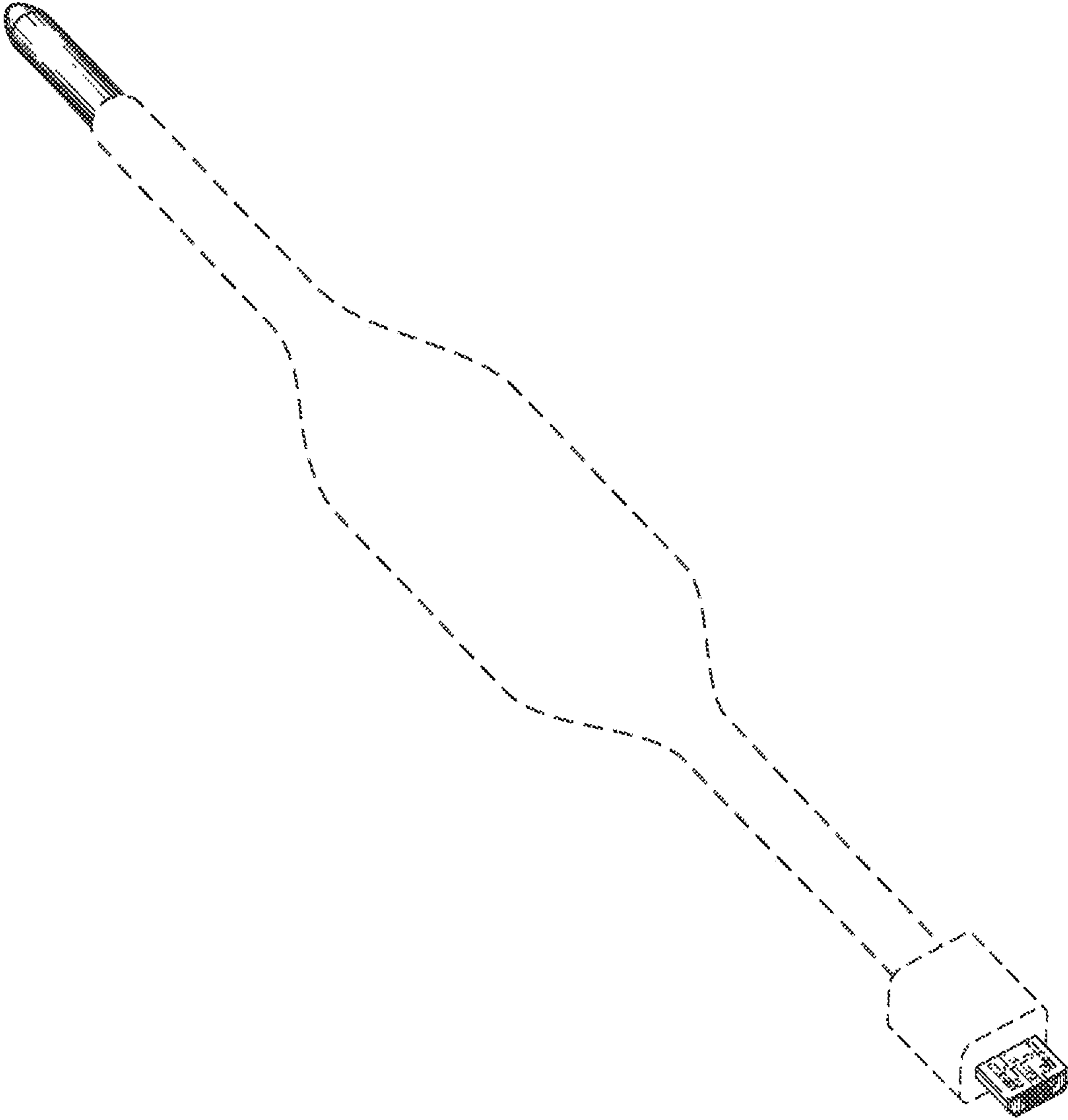


Fig. 1

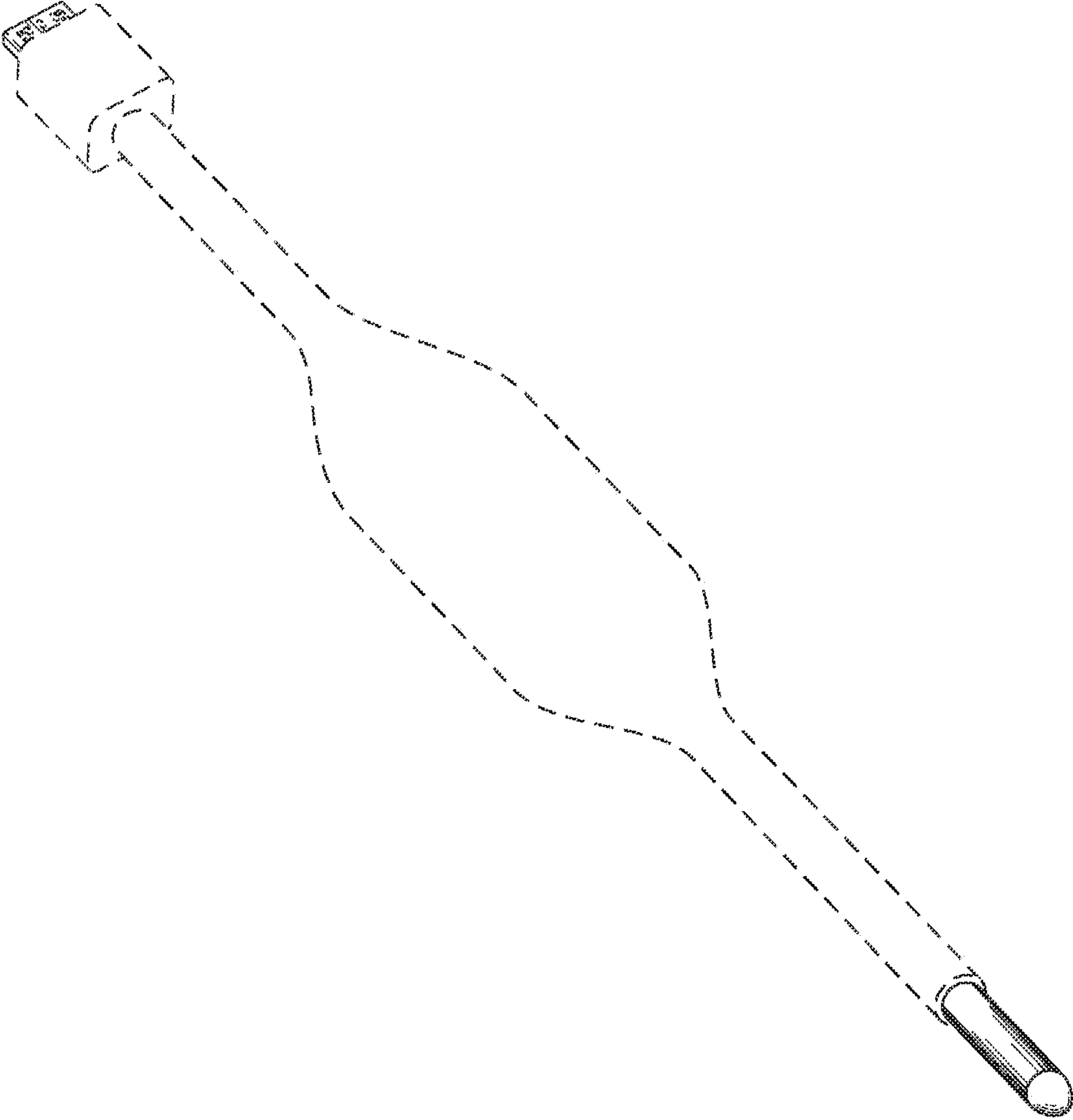


Fig. 2

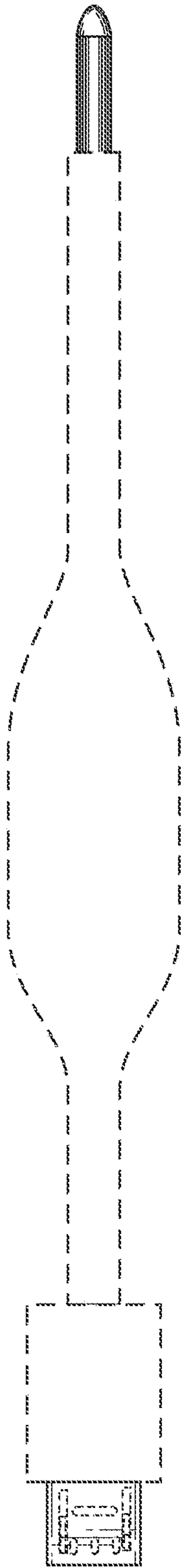


Fig. 3

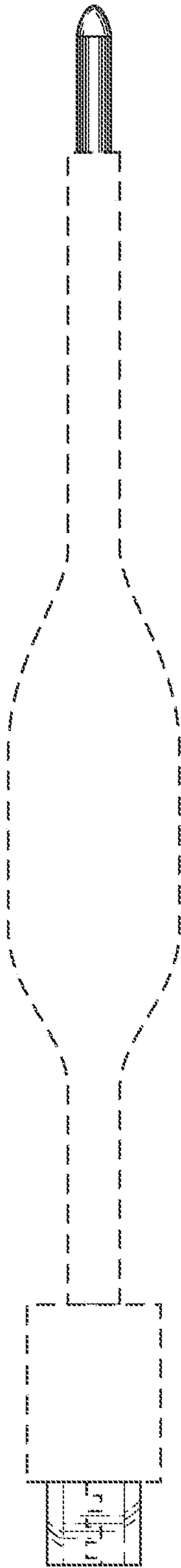


Fig. 4

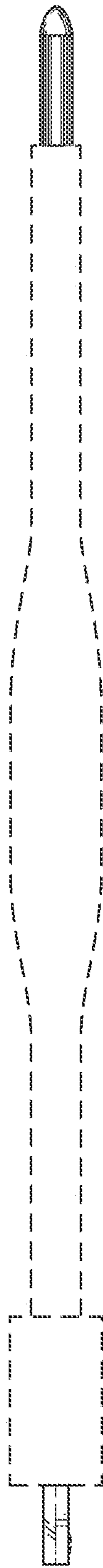


Fig. 5

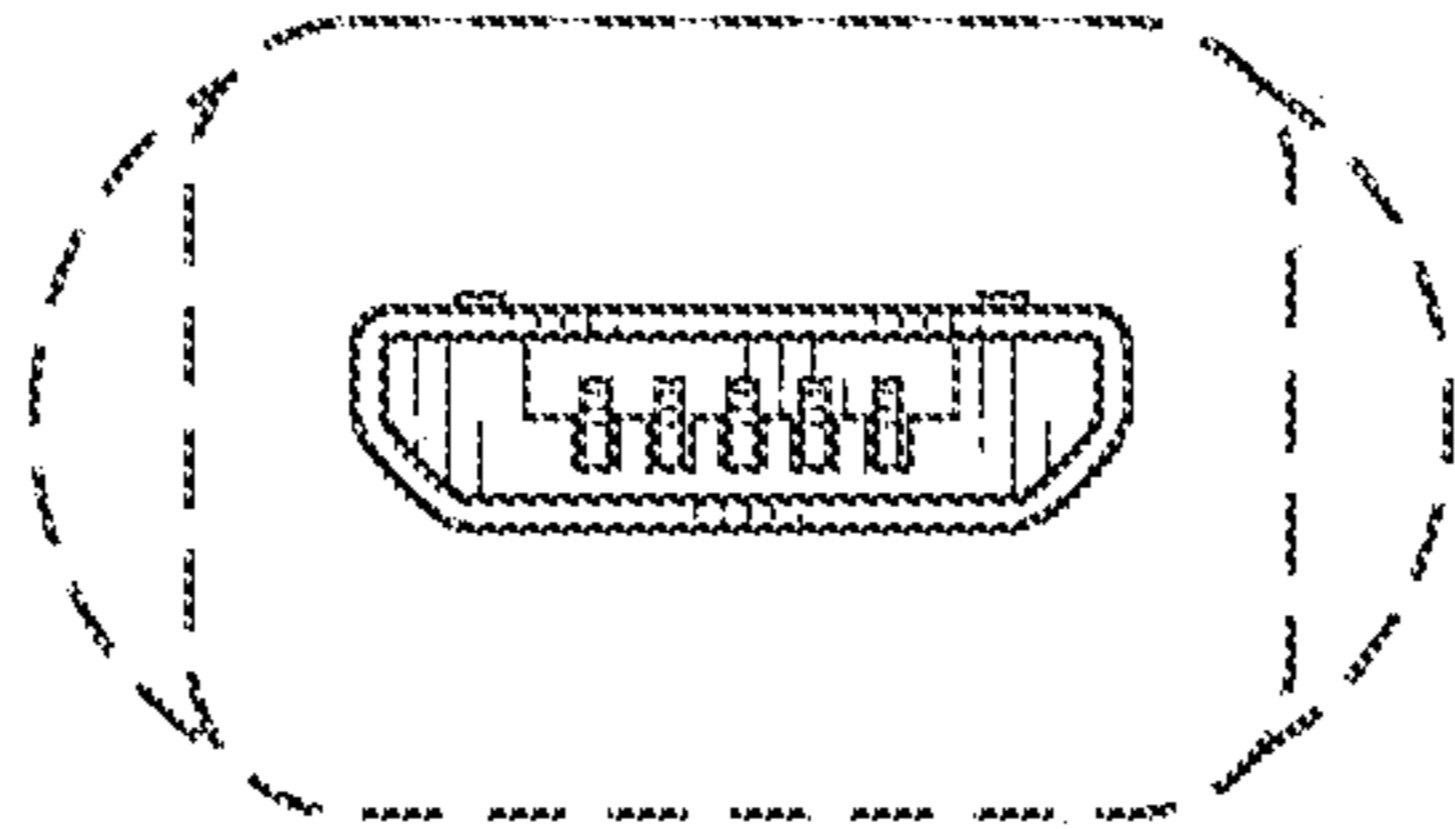


Fig. 6

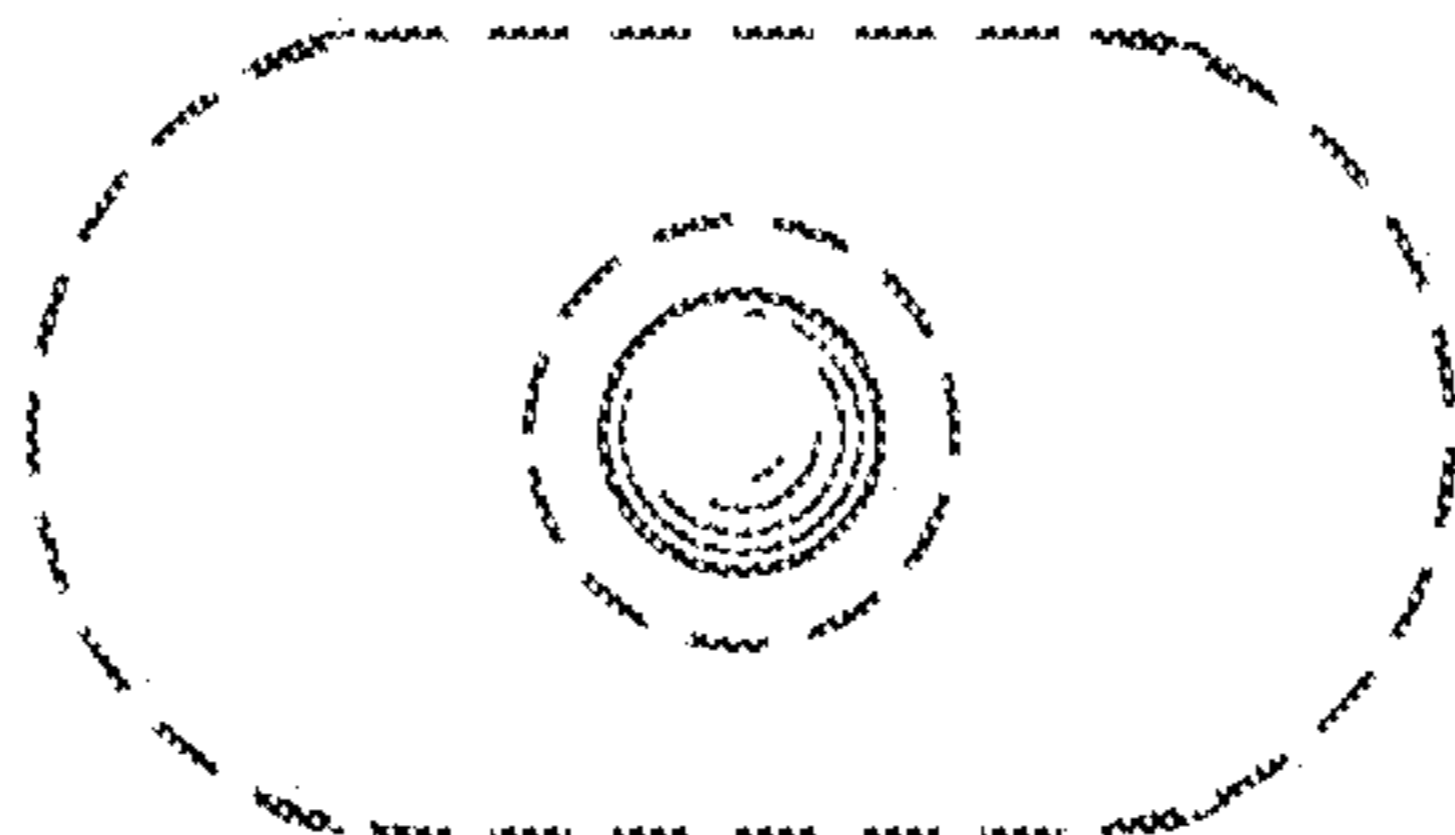


Fig. 7

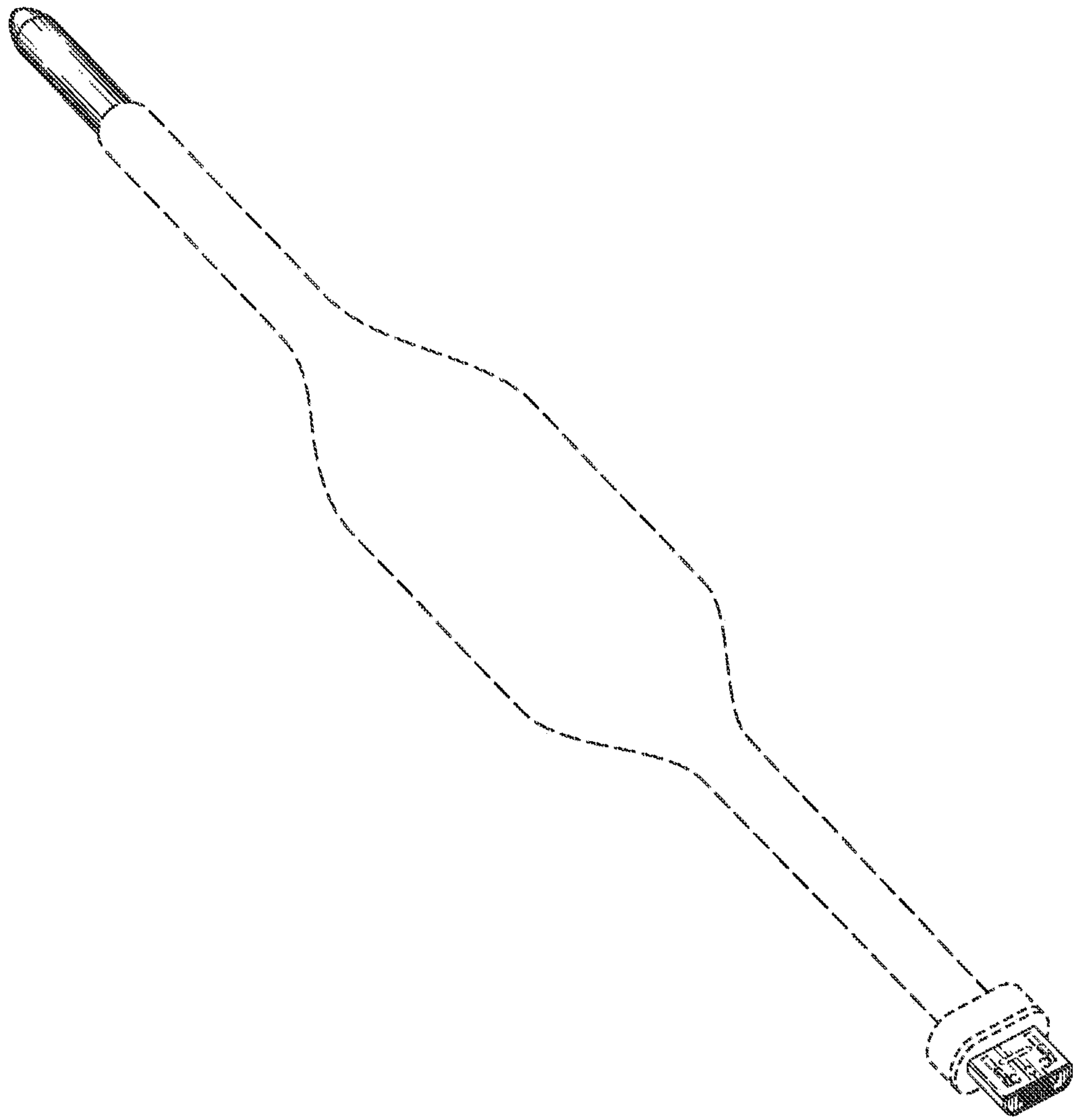


Fig. 8

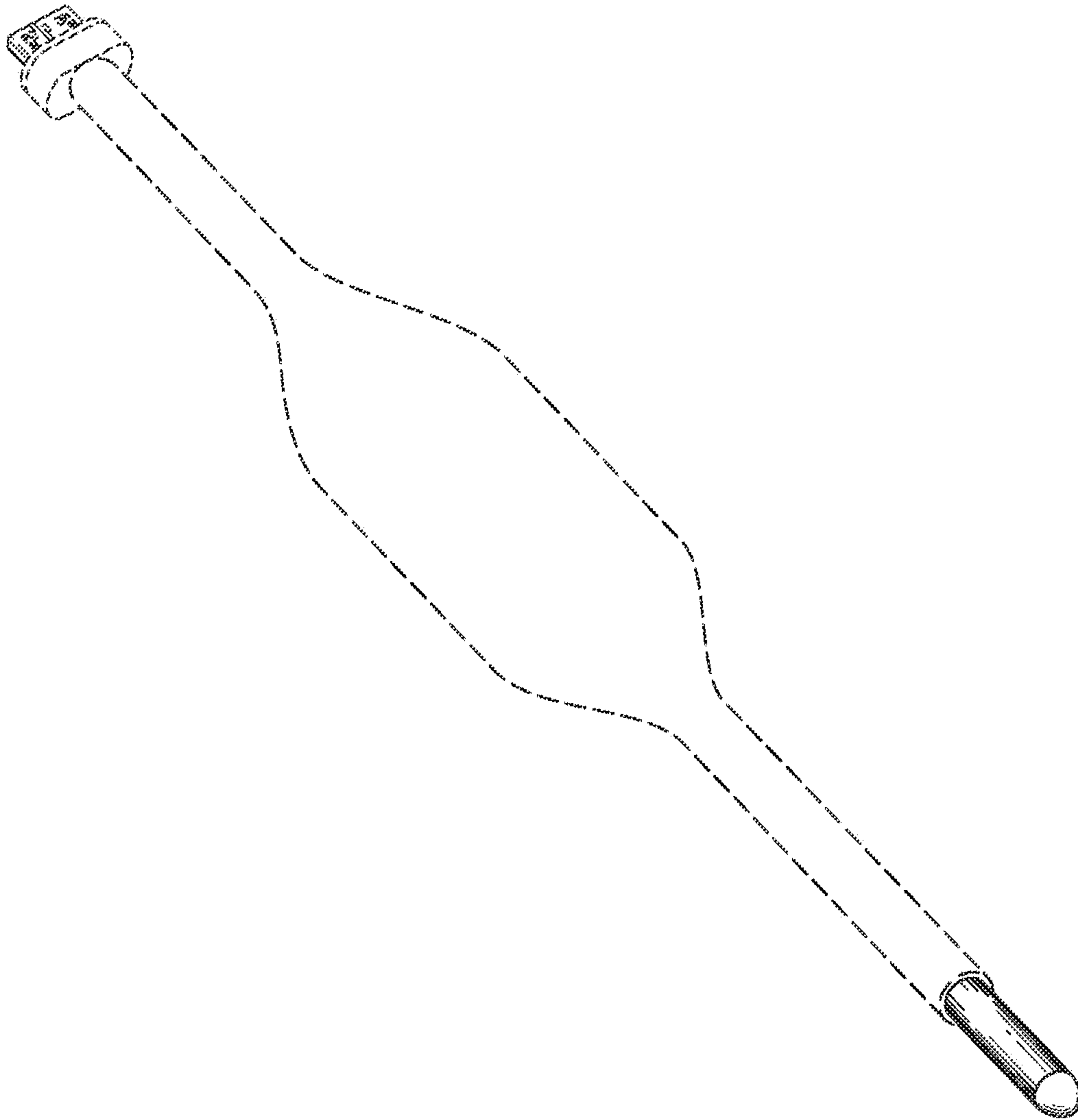


Fig. 9

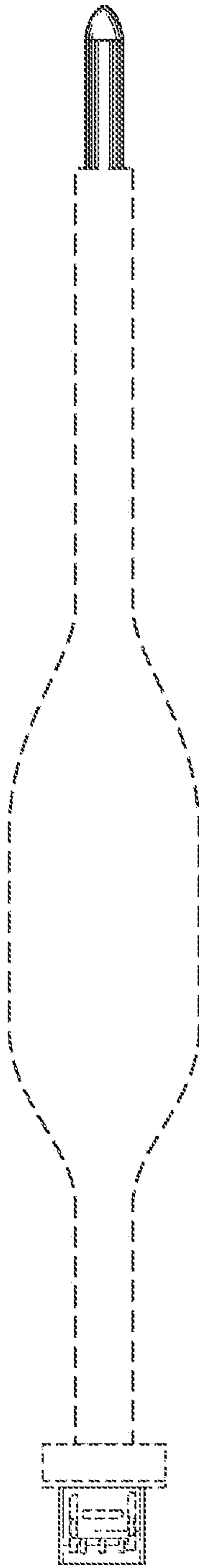


Fig. 10

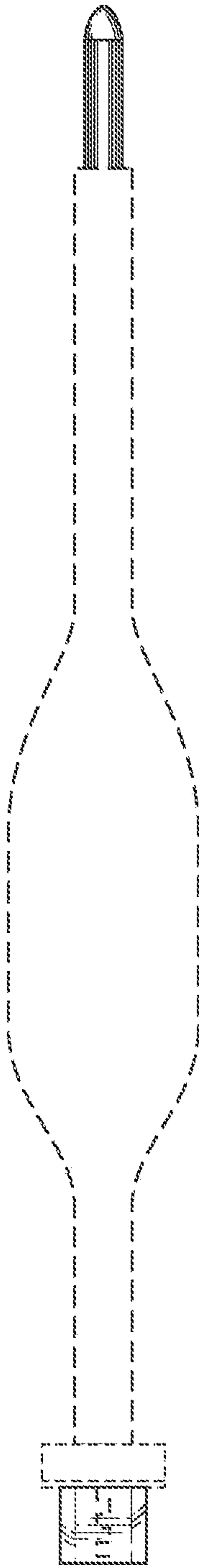


Fig. 11

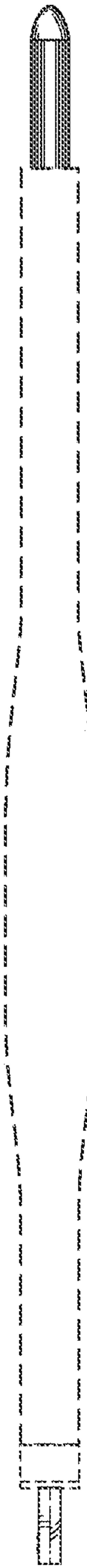


Fig. 12

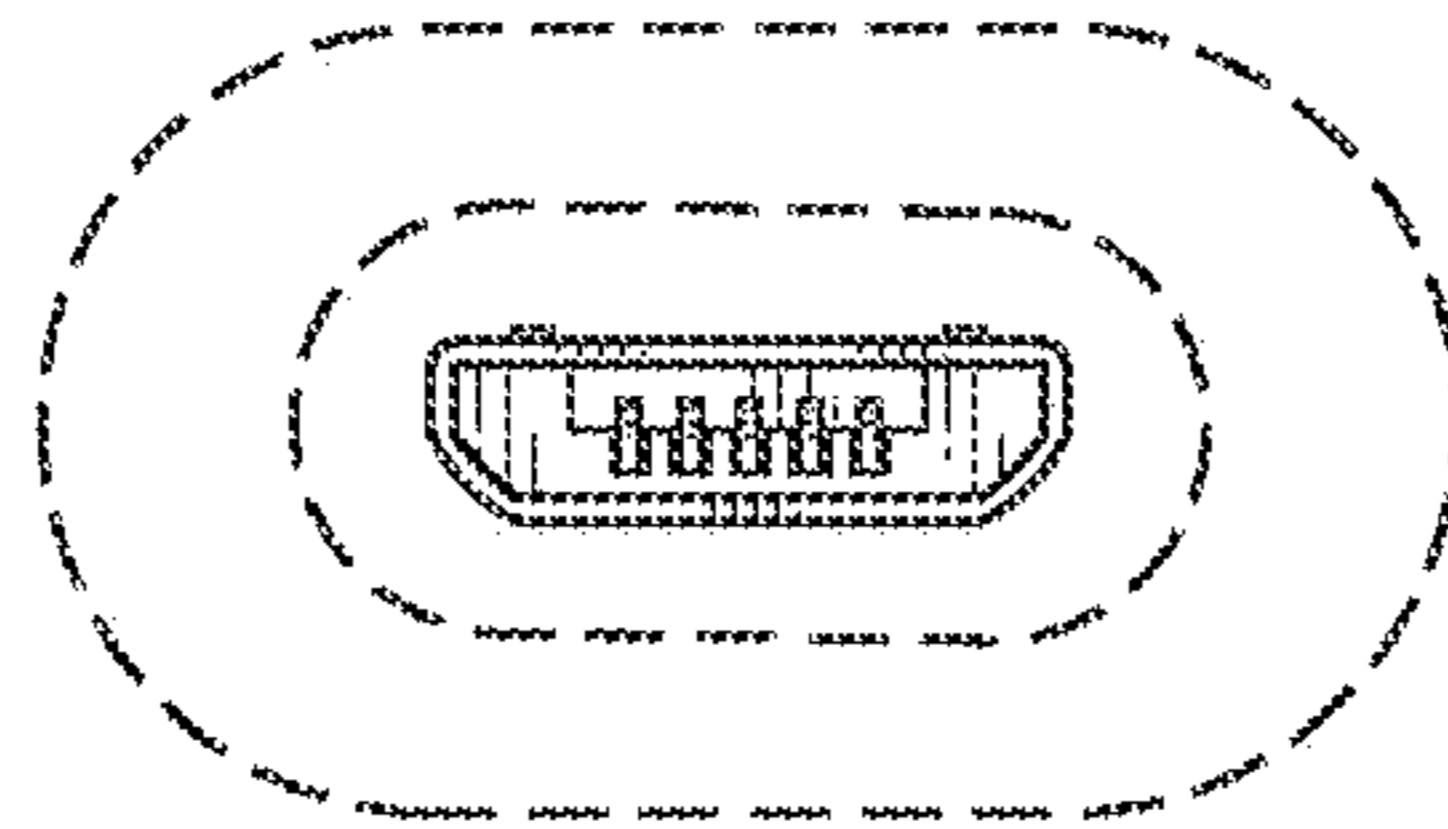


Fig. 13

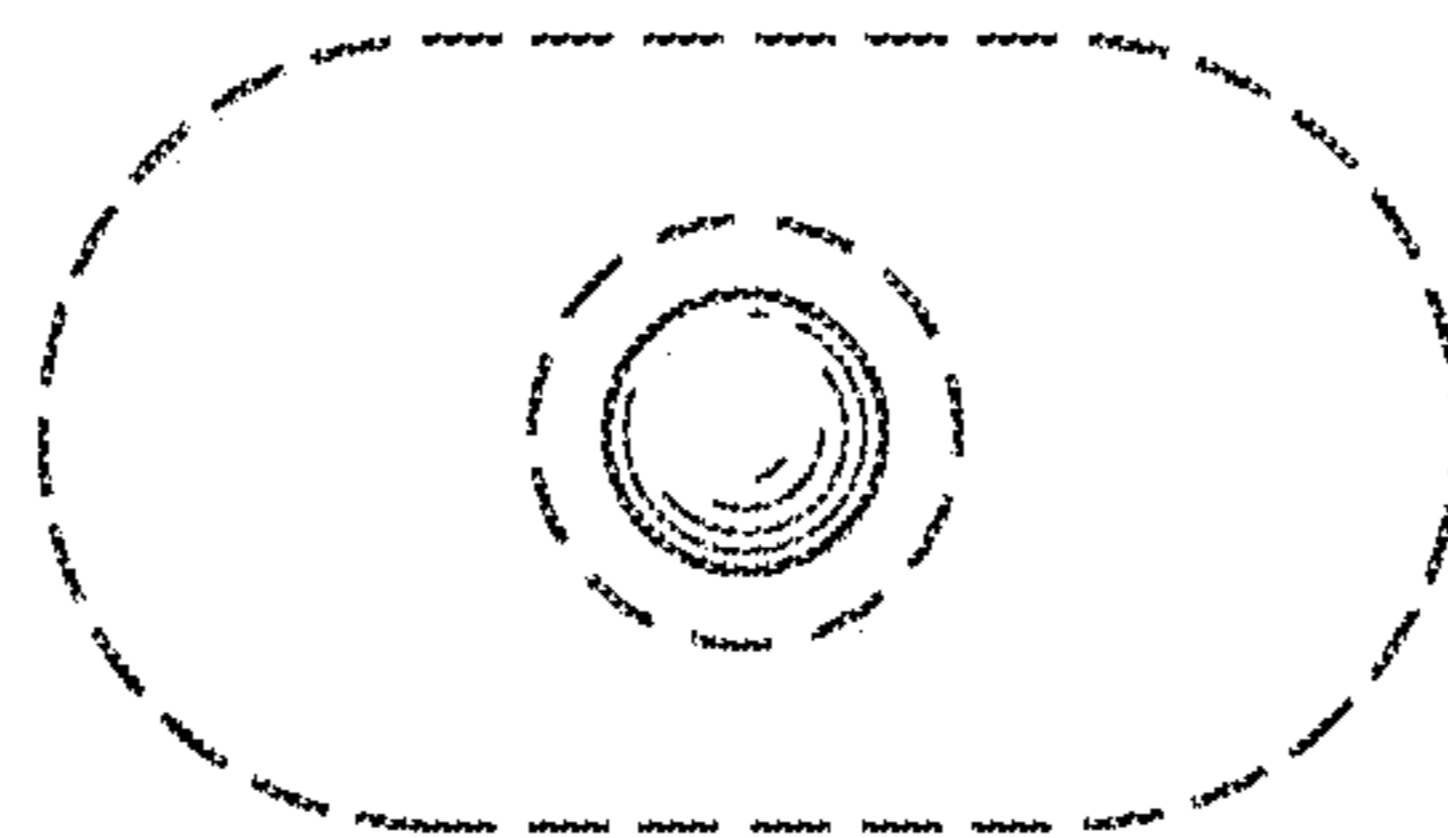


Fig. 14

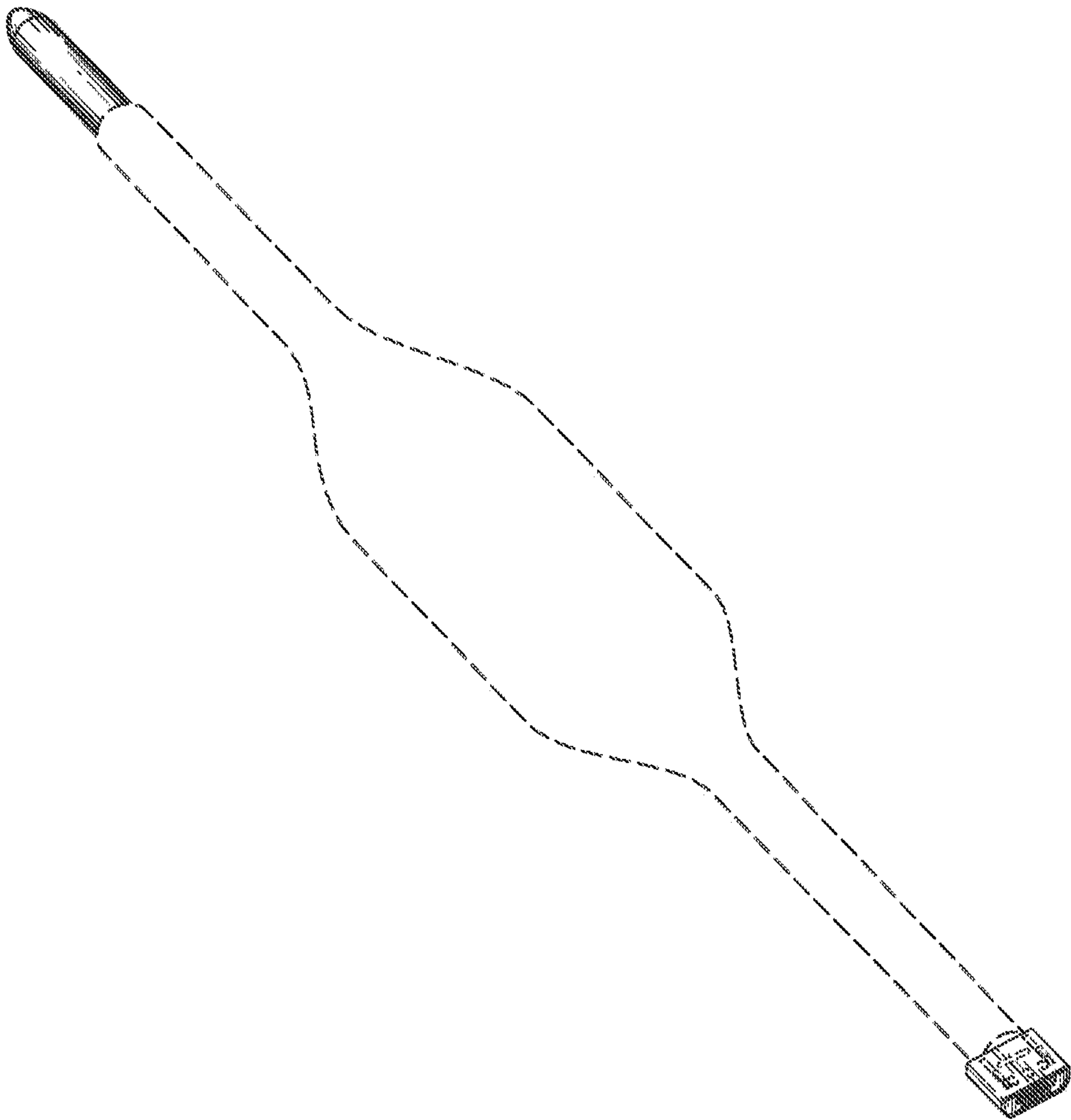


Fig. 15

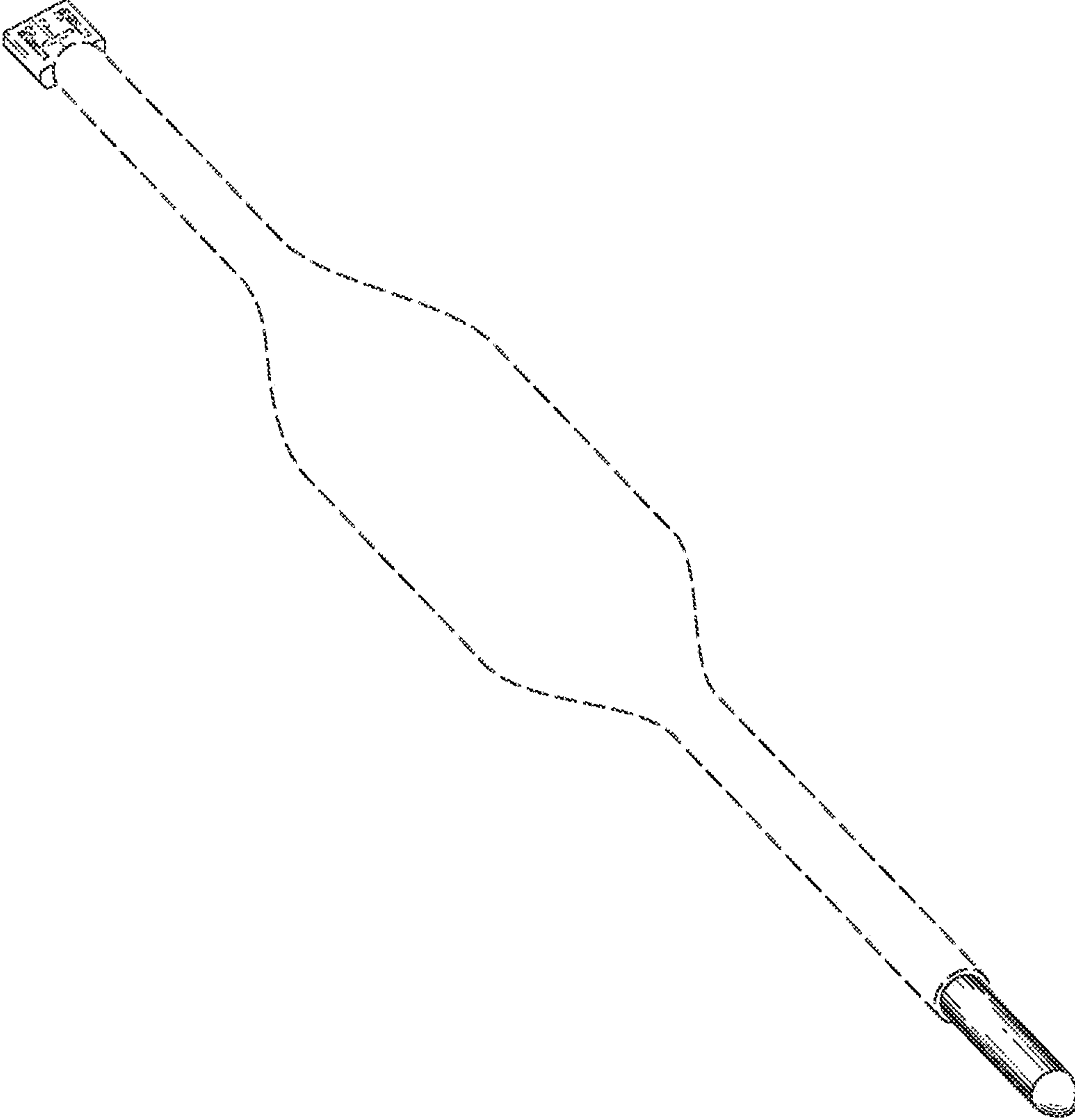


Fig. 16

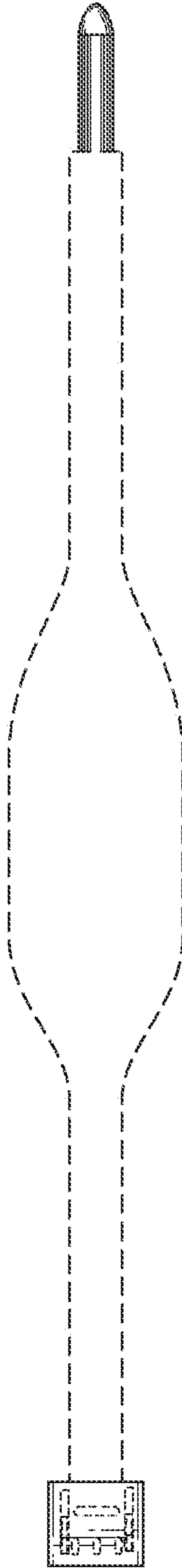


Fig. 17



Fig. 18

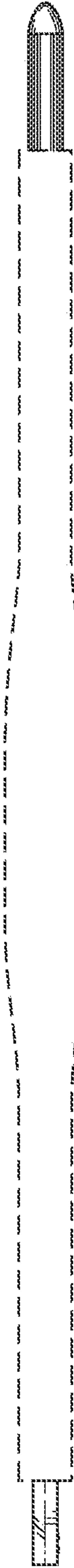


Fig. 19

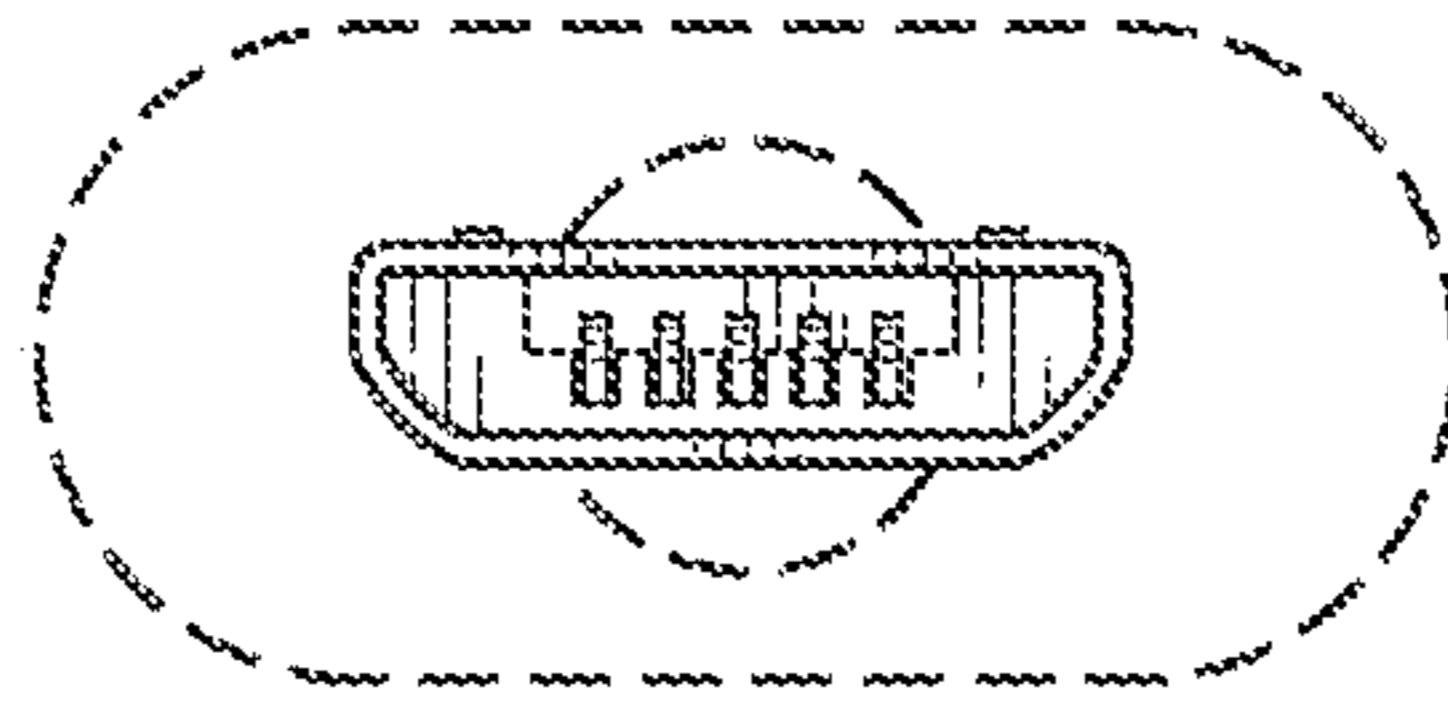


Fig. 20

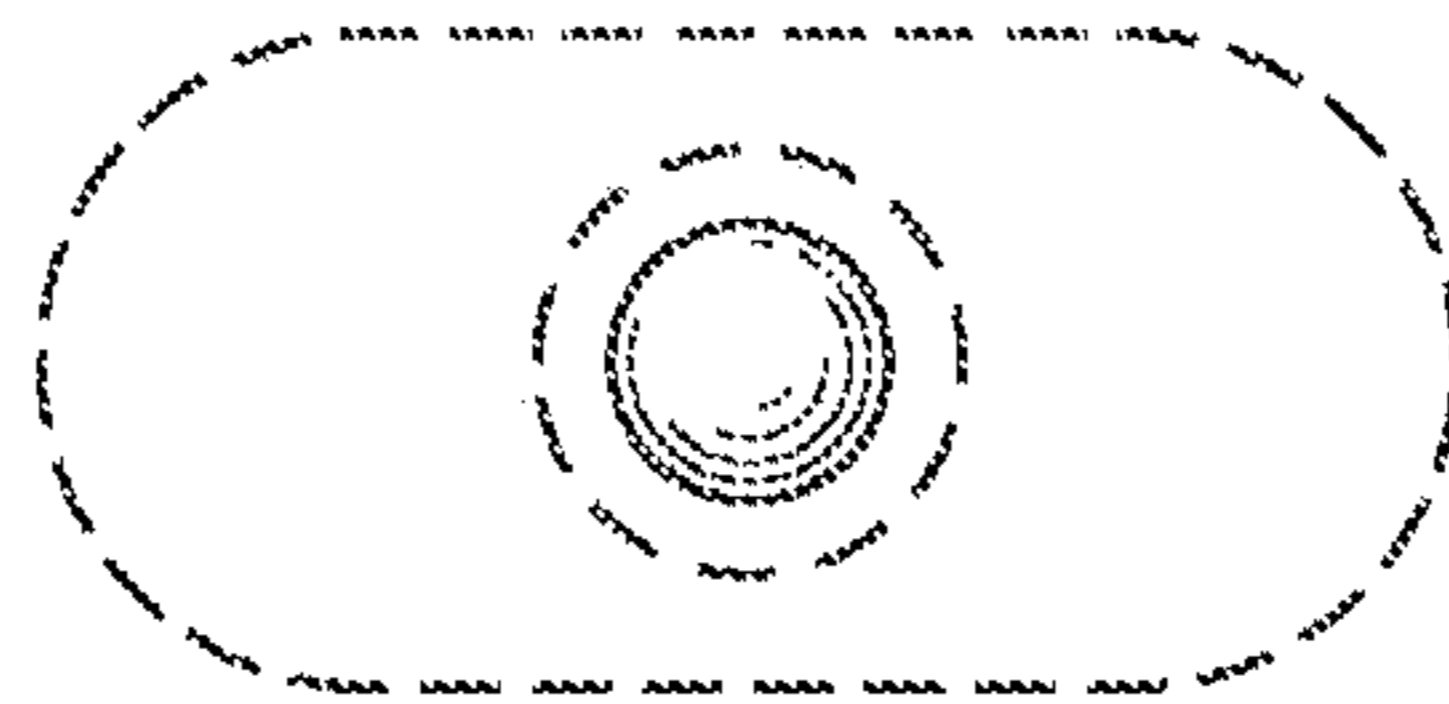


Fig. 21